







SN54AHC126, SN74AHC126

SCLS257M - DECEMBER 1995 - REVISED AUGUST 2023

### **SNx4AHC126 Quadruple Bus Buffer Gates with 3-State Outputs**

#### 1 Features

- Operating range 2-V to 5.5-V V<sub>CC</sub>
- Low delay, 3.8 ns (typical with 5-V supply)
- Latch-up performance exceeds 250 mA per JESD 17

### 2 Applications

- **Drive indicator LEDs**
- Drive transmission lines with logic
- Enable or disable a digital signal

#### 3 Description

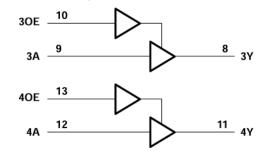
The SNx4AHC126 devices are quadruple bus buffer gates featuring independent line drivers with 3-state outputs.

For the high-impedance state during power up or power down, OE can be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the drive.

#### **Package Information**

PART NUMBER	PART NUMBER PACKAGE <sup>(1)</sup>		BODY SIZE (NOM) <sup>(3)</sup>
SNx4AHC126	BQA (WQFN, 14)	3 mm × 2.5 mm	3 mm × 2.5 mm
SINAMALIC 120	PW (TSSOP, 14)	5 mm × 6.4 mm	5 mm × 4.4 mm

- For all available packages, see the orderable addendum at the end of the data sheet.
- The package size (length × width) is a nominal value and includes pins, where applicable.
- The body size (length × width) is a nominal value and does not include pins.



Logic Diagram (Positive Logic)



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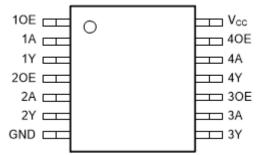
### **4 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

С	hanges from Revision L (July 2003) to Revision M (August 2023)	Page
•	Changed the numbering format for tables, figures, and cross-references throughout the document	1
•	Added the BQA package to the data sheet	1
•	Deleted the J, W, D, DB, DGV, N, NS, and FK packages from the data sheet	<mark>1</mark>



### **5 Pin Configuration and Functions**





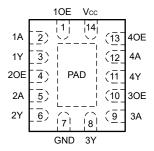


Figure 5-2. BQA Package, WQFN 14-Pin (Transparent Top View)

**Table 5-1. Pin Functions** 

PIN		TYPE(1)	DESCRIPTION
NAME	NO.	ITPE("	DESCRIPTION
10E	1	I	Channel 1, output enable
1A	2	I	Channel 1, A input
1Y	3	0	Channel 1, Y output
20E	4	I	Channel 2, output enable
2A	5	I	Channel 2, A input
2Y	6	0	Channel 2, Y output
GND	7	G	Ground
3Y	8	0	Channel 3, Y output
3A	9	I	Channel 3, A input
30E	10	I	Channel 3, OE input
4Y	11	0	Channel 4, Y output
4A	12	I	Channel 4, A input
40E	13	I	Channel 4, OE input
V <sub>CC</sub>	14	Р	Positive supply
Thermal Pa	d <sup>(2)</sup>	_	Thermal pad; connect to GND or leave floating

<sup>(1)</sup> I = input, O = output, P = power, G = ground

<sup>(2)</sup> BQA package only



### **6 Specifications**

### **6.1 Absolute Maximum Ratings**

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT	
V <sub>CC</sub>	Supply voltage range		-0.5	7	V	
V <sub>I</sub> (2)	Input voltage range	Input voltage range				
V <sub>O</sub> (2)	Output voltage range		-0.5	V <sub>CC</sub> + 0.5	V	
I <sub>IK</sub>	Input clamp current	(V <sub>I</sub> < 0)		-20	mA	
I <sub>OK</sub>	Output clamp current	$(V_O < 0 \text{ or } V_O > V_{CC})$		±20	mA	
Io	Continuous output current	(V <sub>O</sub> = 0 to V <sub>CC</sub> )		±25	mA	
	Continuous current through V <sub>CC</sub> or GN	ID		±50	mA	
T <sub>stg</sub>	Storage temperature range		-65	150	°C	

<sup>(1)</sup> Operation outside the Absolute Maximum Rating may cause permanent device damage. Absolute Maximum Rating do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Condition. If used outside the Recommended Operating Condition but within the Absolute Maximum Rating, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

#### 6.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000	V
V <sub>(ESD)</sub>	discharge	Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 <sup>(2)</sup>	±1000	, <b>v</b>

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

<sup>(2)</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.



### **6.3 Recommended Operating Conditions**

			MIN	MAX	UNIT	
V <sub>CC</sub>	Supply voltage		2	5.5	V	
		V <sub>CC</sub> = 2 V	1.5			
V <sub>IH</sub>	High-level input voltage	V <sub>CC</sub> = 3 V	2.1		V	
		V <sub>CC</sub> = 5.5 V	3.85			
		V <sub>CC</sub> = 2 V		0.5		
V <sub>IL</sub>	Low-level input voltage	V <sub>CC</sub> = 3 V		0.9	V	
		V <sub>CC</sub> = 5.5 V		1.65		
V <sub>I</sub> (1)	Input voltage		0	5.5	V	
Vo	Output voltage		0	V <sub>CC</sub>	V	
		V <sub>CC</sub> = 2 V		-50	μA	
I <sub>OH</sub> <sup>(2)</sup>	High-level output current	V <sub>CC</sub> = 3.3 V ± 0.3 V		-4	mA	
		V <sub>CC</sub> = 5 V ± 0.5 V		-8		
		V <sub>CC</sub> = 2 V		50	μA	
I <sub>OL</sub> (2)	Low-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		4	m A	
		V <sub>CC</sub> = 5 V ± 0.5 V		8	mA	
A 4 / A > .	Input transition rice or fall rate	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		100	na/\/	
Δt/Δv	Input transition rise or fall rate	V <sub>CC</sub> = 5 V ± 0.5 V		20	ns/V	
_	Operating free air temperature	SN74AHC126	-40	85	°C	
T <sub>A</sub>	Operating free-air temperature	SN54AHC126	-55	125	°C	

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND for proper device operation. Refer to the TI application report, *Implications* of Slow or Floating CMOS Inputs, literature number SCBA004.

#### **6.4 Thermal Information**

		SN74AHC126							
	THERMAL METRIC <sup>(1)</sup>	D	DB	DGV	N	NS	PW	UNIT	
			14 PINS						
R <sub>θJA</sub>	Junction-to-ambient thermal resistance						147.7		
R <sub>θJC(top)</sub>	Junction-to-case (top) thermal resistance						77.4		
$R_{\theta JB}$	Junction-to-board thermal resistance						90.9		
Ψлт	Junction-to-top characterization parameter						27.2	°C/W	
ΨЈВ	Junction-to-board characterization parameter						90.2		
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	N/A	N/A	N/A		

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

<sup>(2)</sup> Recommended current values provided to maintain appropriate output state as per the relevant output voltage specification (V<sub>OL</sub> for I<sub>OL</sub>, V<sub>OH</sub> for I<sub>OH</sub>). See *Electrical Characteristics* table for details.



#### 6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V	T <sub>A</sub> = 25 °C			-40 to +85 °C		–55 to +125 °C		UNIT
PARAMETER	1231 CONDITIONS	V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
V <sub>он</sub>		2 V	1.9	2		1.9		1.9		
	I <sub>OH</sub> = -50 μA	3 V	2.9	3		2.9		2.9		
		4.5 V	4.4	4.5		4.4		4.4		V
	I <sub>OH</sub> = -4 mA	3 V	2.58			2.48		2.48		
	I <sub>OH</sub> = -8 mA	4.5 V	3.94			3.8		3.8		
	Ι <sub>ΟL</sub> = 50 μΑ	2 V			0.1		0.1		0.1	
		3 V			0.1		0.1		0.1	
V <sub>OL</sub>		4.5 V			0.1		0.1		0.1	V
	I <sub>OL</sub> = 4 mA	3 V			0.36		0.44		0.5	
	I <sub>OL</sub> = 8 mA	4.5 V			0.36		0.44		0.5	
I <sub>I</sub>	V <sub>I</sub> = 5.5 V or GND	0 V to 5.5 V			±0.1		±1		±1 <sup>(1)</sup>	μA
I <sub>OZ</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	5.5 V			±0.25				±2.5	μΑ
I <sub>CC</sub>	$V_1 = V_{CC}$ or $I_0 = 0$	5.5 V			4				40	μА
C <sub>i</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	5 V		4	10		10			pF

<sup>(1)</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested at  $V_{CC} = 0 \text{ V}$ .

### 6.6 Switching Characteristics, $V_{CC}$ = 3.3 V ± 0.3 V

over recommended operating free-air temperature range,  $V_{CC}$  = 3.3 V ± 0.3 V (unless otherwise noted) (see Section 7)

	FROM		LOAD	T,	<sub>A</sub> = 25°C	;	-40 to +	85 °C	–55 to +125 °C		LINIT	
PARAMETER	(INPUT)	TO (OUTPUT)	CAPACITANC E	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
t <sub>PLH</sub>	А	Y	C <sub>I</sub> = 15 pF		5.6 <sup>(1)</sup>	8(1)	1	9.5	1 <sup>(1)</sup>	9.5 <sup>(1)</sup>	ns	
t <sub>PHL</sub>	^		I	C <sub>L</sub> = 13 μι		5.6 <sup>(1)</sup>	8(1)	1	9.5	1 <sup>(1)</sup>	9.5 <sup>(1)</sup>	115
t <sub>PZH</sub>	OE	Y	C <sub>L</sub> = 15 pF		5.4 <sup>(1)</sup>	8(1)	1	9.5	1 <sup>(1)</sup>	9.5 <sup>(1)</sup>	ns	
t <sub>PZL</sub>		I	CL = 13 pr		5.4 <sup>(1)</sup>	8(1)	1	9.5	1 <sup>(1)</sup>	9.5 <sup>(1)</sup>	115	
t <sub>PHZ</sub>	OE	Υ	C <sub>L</sub> = 15 pF		7 <sup>(1)</sup>	9.7 <sup>(1)</sup>	1	11.5	1 <sup>(1)</sup>	11.5 <sup>(1)</sup>	ns	
t <sub>PLZ</sub>	OL OL	I	G <sub>L</sub> = 13 μr		7 <sup>(1)</sup>	9.7 <sup>(1)</sup>	1	11.5	1 <sup>(1)</sup>	11.5 <sup>(1)</sup>	113	
t <sub>PLH</sub>	А	Y	C <sub>1</sub> = 50 pF		8.1	11.5	1	13	1	13	no	
t <sub>PHL</sub>	A	Ī	CL = 50 pr		8.1	11.5	1	13	1	13	ns	
t <sub>PZH</sub>	OE	Y	C <sub>L</sub> = 50 pF		7.9	11.5	1	13	1	13	ns	
t <sub>PZL</sub>	OL	I	CL = 30 pr		7.9	11.5	1	13	1	13	115	
t <sub>PHZ</sub>	OE	Y	C <sub>L</sub> = 50 pF		9.5	13.2	1	15	1	15	ne	
t <sub>PLZ</sub>		Ţ	CL = 50 pr		9.5	13.2	1	15	1	15	ns	
t <sub>sk(o)</sub>			C <sub>L</sub> = 50 pF			1.5 <sup>(2)</sup>		1.5			ns	

(1) (2)



### 6.7 Switching Characteristics, $V_{CC} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range, V<sub>CC</sub> = 5 V ± 0.5 V (unless otherwise noted) (see Section 7)

PARAMETE	FROM		LOAD	T,	4 = 25°C		-40 to +	-85 °C	–55 to +125 °C		UNIT	
R	(INPUT)	TO (OUTPUT)	CAPACITAN CE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
t <sub>PLH</sub>	А	Y	C <sub>L</sub> = 15 pF		3.8(1)	5.5 <sup>(1)</sup>	1	6.5	1 <sup>(1)</sup>	6.5 <sup>(1)</sup>	no	
t <sub>PHL</sub>	_ ^	ı	CL = 15 pr		3.8(1)	5.5 <sup>(1)</sup>	1	6.5	1 <sup>(1)</sup>	6.5 <sup>(1)</sup>	ns	
t <sub>PZH</sub>	OE	Υ	C <sub>1</sub> = 15 pF		3.6 <sup>(1)</sup>	5.1 <sup>(1)</sup>	1	6	1 <sup>(1)</sup>	6 <sup>(1)</sup>	ns	
t <sub>PZL</sub>	OE	1	OL = 13 pr		3.6 <sup>(1)</sup>	5.1 <sup>(1)</sup>	1	6	1 <sup>(1)</sup>	6 <sup>(1)</sup>	115	
t <sub>PHZ</sub>	OE	Y	C <sub>L</sub> = 15 pF		4.6(1)	6.8 <sup>(1)</sup>	1	8	1 <sup>(1)</sup>	8(1)	ns	
t <sub>PLZ</sub>	OE	ı	OL - 13 pr		4.6(1)	6.8 <sup>(1)</sup>	1	8	1 <sup>(1)</sup>	8(1)	113	
t <sub>PLH</sub>	A Y		C <sub>L</sub> = 50 pF		5.3	7.5	1	8.5	1	8.5	ns	
t <sub>PHL</sub>		1			5.3	7.5	1	8.5	1	8.5	115	
t <sub>PZH</sub>	OE	Y	C <sub>L</sub> = 50 pF		5.1	7.1	1	8	1	8	ns	
t <sub>PZL</sub>	OL	1	CL = 30 pr		5.1	7.1	1	8	1	8	115	
t <sub>PHZ</sub>	OE	OE Y	0 - 50 - 5		6.1	8.8	1	10	1	10		
t <sub>PLZ</sub>			ī	C <sub>L</sub> = 50 pF		6.1	8.8	1	10	1	10	ns
t <sub>sk(o)</sub>			C <sub>L</sub> = 50 pF			1 <sup>(2)</sup>		1			ns	

<sup>(1)</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.

#### 6.8 Noise Characteristics

 $V_{CC}$  = 5 V,  $C_L$  = 50 pF,  $T_A$  = 25° $C^{(1)}$ 

	PARAMETER	MIN	TYP	MAX	UNIT
V <sub>OL(P)</sub>	Quiet output, maximum dynamic V <sub>OL</sub>		0.2	0.8	V
V <sub>OL(V)</sub>	Quiet output, minimum dynamic V <sub>OL</sub>	-0.9	-0.2		V
V <sub>OH(V)</sub>	Quiet output, minimum dynamic V <sub>OH</sub>	4.4	4.7		V
V <sub>IH(D)</sub>	High-level dynamic input voltage	3.5			V
V <sub>IL(D)</sub>	Low-level dynamic input voltage			1.5	V

<sup>(1)</sup> Characteristics are for surface-mount packages only.

### 6.9 Operating Characteristics

 $V_{CC} = 5$  V,  $T_A = 25$ °C

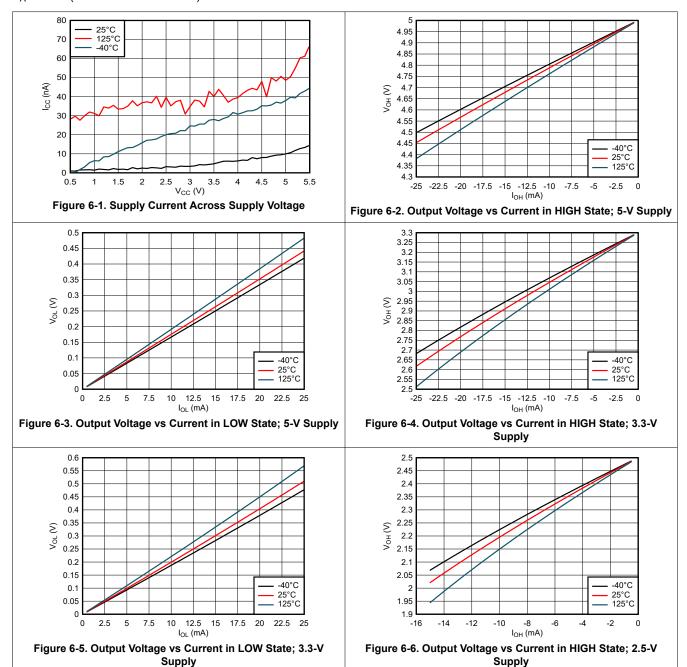
PARAMETER	TEST CONDITIONS	TYP	UNIT
C <sub>pd</sub> Power dissipation capacitance	No load, f = 1 MHz	14	pF

<sup>(2)</sup> On products compliant to MIL-PRF-38535, this parameter does not apply.



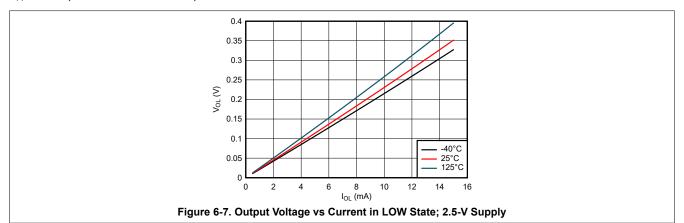
#### 6.10 Typical Characteristics

T<sub>A</sub> = 25°C (unless otherwise noted)



### **6.10 Typical Characteristics (continued)**

T<sub>A</sub> = 25°C (unless otherwise noted)

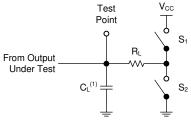


#### 7 Parameter Measurement Information

Phase relationships between waveforms were chosen arbitrarily for the examples listed in the following table. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O$  = 50  $\Omega$ ,  $t_t$  < 2.5 ns.

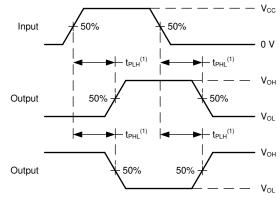
The outputs are measured individually with one input transition per measurement.

TEST	<b>S</b> 1	S2	S2 R <sub>L</sub> C <sub>L</sub>		ΔV	V <sub>CC</sub>
t <sub>PLH</sub> , t <sub>PHL</sub>	OPEN	OPEN	_	15 pF, 50 pF	_	ALL
t <sub>PLZ</sub> , t <sub>PZL</sub>	CLOSED	OPEN	1 kΩ	15 pF, 50 pF	0.15 V	≤ 2.5 V
t <sub>PHZ</sub> , t <sub>PZH</sub>	OPEN	CLOSED	1 kΩ	15 pF, 50 pF	0.15 V	≤ 2.5 V
t <sub>PLZ</sub> , t <sub>PZL</sub>	CLOSED	OPEN	1 kΩ	15 pF, 50 pF	0.3 V	> 2.5 V
t <sub>PHZ</sub> , t <sub>PZH</sub>	OPEN	CLOSED	1 kΩ	15 pF, 50 pF	0.3 V	> 2.5 V



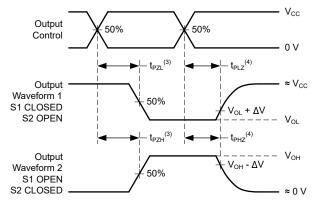
(1)  $C_L$  includes probe and test-fixture capacitance.

Figure 7-1. Load Circuit for 3-State Outputs



(1) The greater between t<sub>PLH</sub> and t<sub>PHL</sub> is the same as t<sub>pd</sub>.

Figure 7-2. Voltage Waveforms Propagation Delays



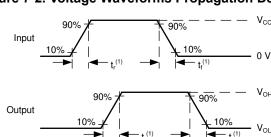
- (3) The greater between  $t_{PZL}$  and  $t_{PZH}$  is the same as  $t_{en}$ .
- (4) The greater between  $t_{\text{PLZ}}$  and  $t_{\text{PHZ}}$  is the same as  $t_{\text{dis}}$ .

Figure 7-3. Voltage Waveforms Propagation Delays



Noise values measured with all other outputs simultaneously switching.

Figure 7-5. Voltage Waveforms, Noise



(1) The greater between t<sub>r</sub> and t<sub>f</sub> is the same as t<sub>t</sub>.

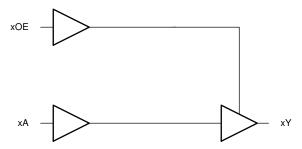
Figure 7-4. Voltage Waveforms, Input and Output Transition Times

#### 8 Detailed Description

#### 8.1 Overview

This device contains four independent buffers with 3-state outputs. Each gate performs the Boolean function Y = A in positive logic.

#### 8.2 Functional Block Diagram



One of four channels

#### 8.3 Feature Description

#### 8.3.1 Balanced CMOS 3-State Outputs

This device includes balanced CMOS 3-state outputs. Driving high, driving low, and high impedance are the three states that these outputs can be in. The term *balanced* indicates that the device can sink and source similar currents. The drive capability of this device may create fast edges into light loads, so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device can drive larger currents than the device can sustain without being damaged. It is important for the output power of the device to be limited to avoid damage due to overcurrent. The electrical and thermal limits defined in the *Absolute Maximum Ratings* must be followed at all times.

When placed into the high-impedance mode, the output will neither source nor sink current, with the exception of minor leakage current as defined in the *Electrical Characteristics* table. In the high-impedance state, the output voltage is not controlled by the device and is dependent on external factors. If no other drivers are connected to the node, then this is known as a floating node and the voltage is unknown. A pull-up or pull-down resistor can be connected to the output to provide a known voltage at the output while it is in the high-impedance state. The value of the resistor will depend on multiple factors, including parasitic capacitance and power consumption limitations. Typically, a 10-k $\Omega$  resistor can be used to meet these requirements.

Unused 3-state CMOS outputs should be left disconnected.

#### 8.3.2 Standard CMOS Inputs

This device includes standard CMOS inputs. Standard CMOS inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the *Electrical Characteristics*. The worst case resistance is calculated with the maximum input voltage, given in the *Absolute Maximum Ratings*, and the maximum input leakage current, given in the *Electrical Characteristics*, using Ohm's law  $(R = V \div I)$ .

Standard CMOS inputs require that input signals transition between valid logic states quickly, as defined by the input transition time or rate in the *Recommended Operating Conditions* table. Failing to meet this specification will result in excessive power consumption and could cause oscillations. More details can be found in *Implications of Slow or Floating CMOS Inputs*.

Do not leave standard CMOS inputs floating at any time during operation. Unused inputs must be terminated at  $V_{CC}$  or GND. If a system will not be actively driving an input at all times, then a pull-up or pull-down resistor can be added to provide a valid input voltage during these times. The resistor value will depend on multiple factors; a  $10\text{-k}\Omega$  resistor, however, is recommended and will typically meet all requirements.



#### 8.3.3 Clamp Diode Structure

As Figure 8-1 shows, the outputs to this device have both positive and negative clamping diodes, and the inputs to this device have negative clamping diodes only.

#### **CAUTION**

Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

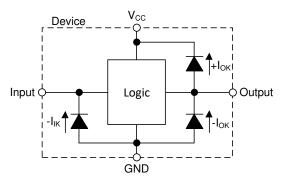


Figure 8-1. Electrical Placement of Clamping Diodes for Each Input and Output

#### **8.4 Device Functional Modes**

**Table 8-1. Function Table** 

INP	UTS	OUTPUT
OE	Α	Y
L	Х	Z
Н	L	L
Н	Н	Н



### 9 Device and Documentation Support

#### 9.1 Documentation Support

#### 9.1.1 Related Documentation

For related documentation, see the following:

Texas Instruments, Implications of Slow or Floating CMOS Inputs

#### 9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 9.3 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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#### 9.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

#### 9.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 9.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

### 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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#### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9686201Q2A	ACTIVE	LCCC	FK	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9686201Q2A SNJ54AHC 126FK	Samples
5962-9686201QDA	ACTIVE	CFP	W	14	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9686201QD A SNJ54AHC126W	Samples
SN74AHC126BQAR	ACTIVE	WQFN	BQA	14	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHC126	Samples
SN74AHC126DBR	ACTIVE	SSOP	DB	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HA126	Samples
SN74AHC126DGVR	ACTIVE	TVSOP	DGV	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HA126	Samples
SN74AHC126DR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AHC126	Samples
SN74AHC126N	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74AHC126N	Samples
SN74AHC126NSR	ACTIVE	SO	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AHC126	Samples
SN74AHC126PWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HA126	Samples
SN74AHC126PWRG4	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HA126	Samples
SNJ54AHC126FK	ACTIVE	LCCC	FK	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9686201Q2A SNJ54AHC 126FK	Samples
SNJ54AHC126W	ACTIVE	CFP	W	14	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9686201QD A SNJ54AHC126W	Samples

<sup>(1)</sup> The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design. PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

### PACKAGE OPTION ADDENDUM

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(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF SN54AHC126, SN74AHC126:

Catalog: SN74AHC126

Automotive: SN74AHC126-Q1, SN74AHC126-Q1

Military: SN54AHC126

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects

### **PACKAGE OPTION ADDENDUM**

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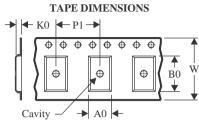
• Military - QML certified for Military and Defense Applications



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#### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

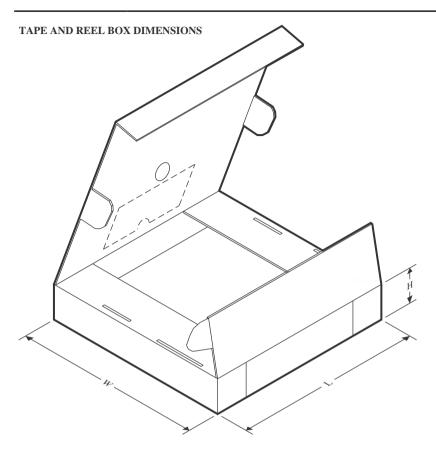


#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AHC126BQAR	WQFN	BQA	14	3000	180.0	12.4	2.8	3.3	1.1	4.0	12.0	Q1
SN74AHC126DBR	SSOP	DB	14	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74AHC126DGVR	TVSOP	DGV	14	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
SN74AHC126DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74AHC126NSR	SO	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74AHC126PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AHC126BQAR	WQFN	BQA	14	3000	210.0	185.0	35.0
SN74AHC126DBR	SSOP	DB	14	2000	356.0	356.0	35.0
SN74AHC126DGVR	TVSOP	DGV	14	2000	356.0	356.0	35.0
SN74AHC126DR	SOIC	D	14	2500	356.0	356.0	35.0
SN74AHC126NSR	SO	NS	14	2000	356.0	356.0	35.0
SN74AHC126PWR	TSSOP	PW	14	2000	356.0	356.0	35.0

## **PACKAGE MATERIALS INFORMATION**

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#### **TUBE**



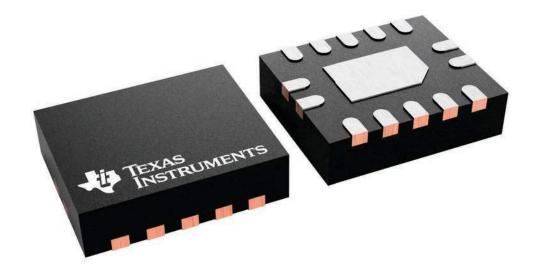
\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-9686201Q2A	FK	LCCC	20	1	506.98	12.06	2030	NA
5962-9686201QDA	W	CFP	14	1	506.98	26.16	6220	NA
SN74AHC126N	N	PDIP	14	25	506	13.97	11230	4.32
SN74AHC126N	N	PDIP	14	25	506	13.97	11230	4.32
SNJ54AHC126FK	FK	LCCC	20	1	506.98	12.06	2030	NA
SNJ54AHC126W	W	CFP	14	1	506.98	26.16	6220	NA

2.5 x 3, 0.5 mm pitch

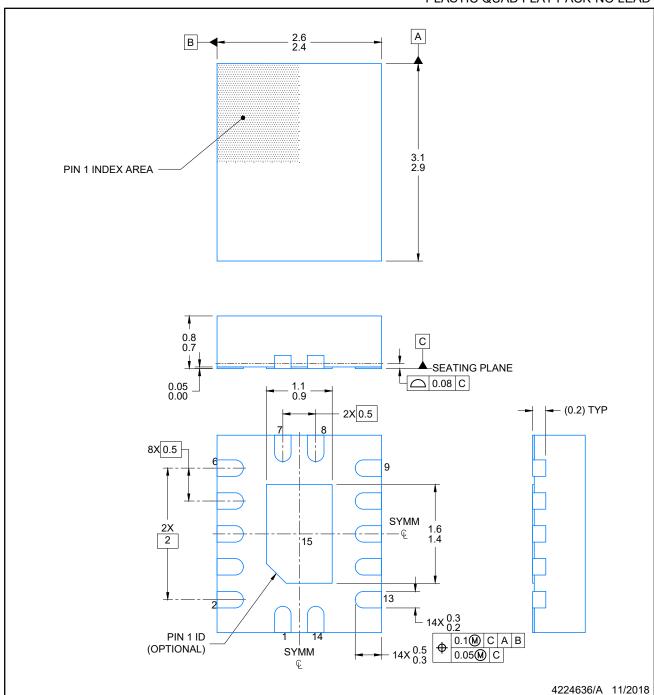
PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



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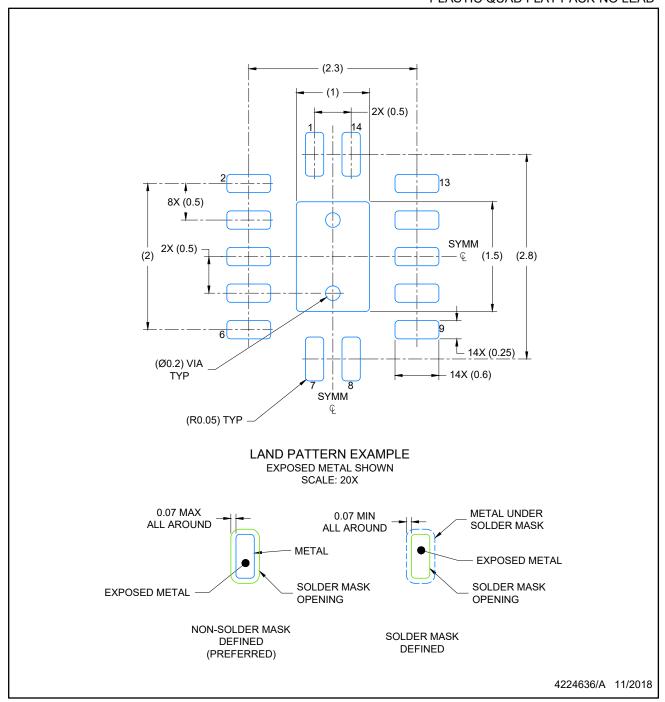
PLASTIC QUAD FLAT PACK-NO LEAD



- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



PLASTIC QUAD FLAT PACK-NO LEAD

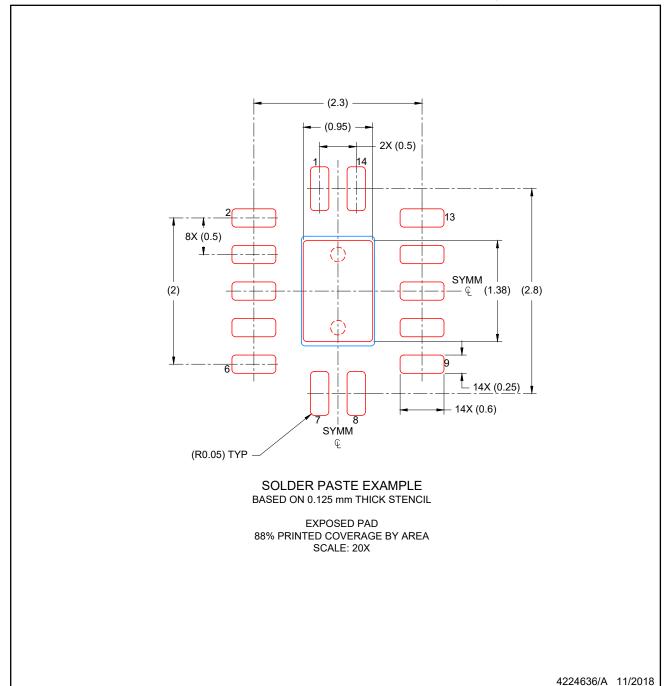


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC QUAD FLAT PACK-NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

### **MECHANICAL DATA**

### NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

#### PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



# W (R-GDFP-F14)

### CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within MIL STD 1835 GDFP1-F14



### DGV (R-PDSO-G\*\*)

#### **24 PINS SHOWN**

#### **PLASTIC SMALL-OUTLINE**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194



8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



## D (R-PDSO-G14)

### PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



# D (R-PDSO-G14)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G14)

### PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



# PW (R-PDSO-G14)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



## N (R-PDIP-T\*\*)

### PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



### DB (R-PDSO-G\*\*)

### PLASTIC SMALL-OUTLINE

#### **28 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

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